BLF6H10L-160; BLF6H10LS-160

Power LDMOS transistor

Rev. 1 — 10 February 2012

Objective data sheet

1. Product profile

1.1 General description

A 160 W LDMOS RF power transistor for base station applications. The transistor can deliver 160 W from HF to 1 GHz. The excellent ruggedness and broadband performance of this device makes it ideal for base station applications.

Table 1. Typical performance

RF performance at $V_{DS} = 50 \text{ V}$ in a common-source Class-AB test circuit.

Test signal	f	I _{Dq}	V _{DS}	P _{L(AV)}	Gp	η _D	ACPR
	(MHz)	(mA)	(V)	(W)	(dB)	(%)	(dBc)
2-carrier W-CDMA	729 to 960	600	50	38	20	27	-32 <mark>[1]</mark>

^[1] Test signal: 3GPP; test model 1; 64 DPCH; PAR = 8.4 dB at 0.01% probability on CCDF.

1.2 Features and benefits

- Integrated ESD protection
- Excellent ruggedness
- High power gain
- High efficiency
- Excellent reliability
- Easy power control
- Low R_{th} providing excellent thermal stability
- Low output capacitance for wideband performance in Doherty applications
- Designed for low memory effects providing excellent digital pre-distortion capability
- No internal matching for broadband applications
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

1.3 Applications

 RF power applications for GSM, GSM EDGE, W-CDMA, CDMA base stations and multi carrier applications in the 700 MHz to 1000 MHz frequency range



2. Pinning information

Table 2. Pinning

Pin	Description		Simplified outline	Graphic symbol
BLF6H10	L-160 (SOT467C)			
1	drain			
2	gate		1	ئے
3	source	<u>[1]</u>	3	2
			2	3 sym112
BLF6H10	LS-160 (SOT467B)			
1	drain			
2	gate			1
3	source	<u>[1]</u>	-3	2
				3
				sym112

^[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Packag	Package			
	Name	Description	Version		
BLF6H10L-160	-	flanged LDMOST ceramic package; 2 mounting holes; 2 leads	SOT467C		
BLF6H10LS-160	-	earless LDMOST ceramic package; 2 leads	SOT467B		

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage		-	104	V
V_{GS}	gate-source voltage		-0.5	+13	V
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions		Тур	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_{case} = 80 ^{\circ}C;$ $P_{L(AV)} = 70 W$	[1]	0.95	K/W

^[1] $R_{th(j-c)}$ is measured under RF conditions.

BLF6H10L-160_6H10LS-160

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Objective data sheet

Rev. 1 — 10 February 2012

6. Characteristics

Table 6. DC characteristics

 $T_i = 25$ °C unless otherwise specified.

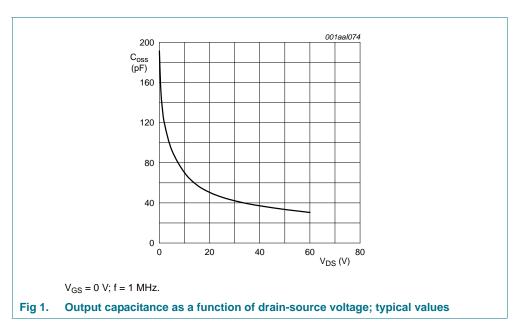
,							
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 1.35 \text{ mA}$	<u>[1]</u>	104	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 135 \text{ mA}$	<u>[1]</u>	1.4	-	2.4	V
I _{DSS}	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}$		-	-	1.4	μΑ
I _{DSX}	drain cut-off current	$V_{GS} = V_{GSth} + 3.75 \text{ V}; V_{DS} = 10 \text{ V}$		-	21	-	Α
I_{GSS}	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}$		-	-	140	nA
R _{DS(on)}	drain-source on-state resistance	$V_{GS} = V_{GSth} + 3.75 \text{ V}; I_D = 4.5 \text{ A}$	<u>[1]</u>	-	210	-	$m\Omega$
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ MHz}$		-	100	-	pF
Coss	output capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ MHz}$		-	33.5	-	pF
C _{rss}	reverse transfer capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ MHz}$		-	1	-	pF

^[1] I_D is the drain current.

Table 7. RF characteristics

 $T_h = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
2-carrier	W-CDMA					
V_{DS}	drain-source voltage		-	50	-	V
I_{Dq}	quiescent drain current		-	600	-	mΑ
$P_{L(AV)}$	average output power		-	38	-	W
Gp	power gain		-	20	-	dB
η_{D}	drain efficiency		-	27	-	%
ACPR	adjacent channel power ratio		-	-32	-	dBc



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7. Application information

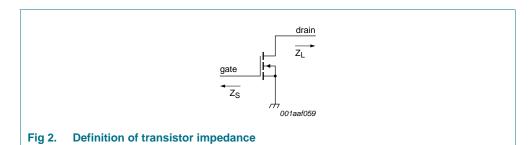
7.1 Ruggedness in class-AB operation

The BLF6H10L-160 and BLF6H10LS-160 are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: $V_{DS} = 50 \text{ V}$; f = 860 MHz at rated power. Ruggedness is measured in the application circuit.

7.2 Impedance information

Table 8. Typical impedance Simulated Z_S and Z_L test circuit impedances.

0 -	•	
f	Z _S	Z _L
(MHz)	(Ω)	(Ω)
925	1.0 – j0.39	2.2 + j0.55
942	1.0 – j0.50	2.2 + j0.45
960	1.0 – j0.58	2.2 + j0.47



8. Package outline

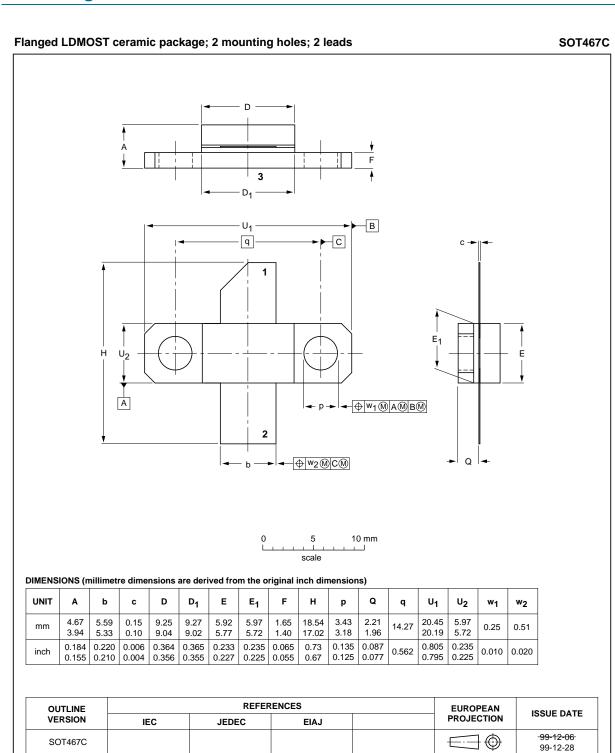


Fig 3. Package outline SOT467C

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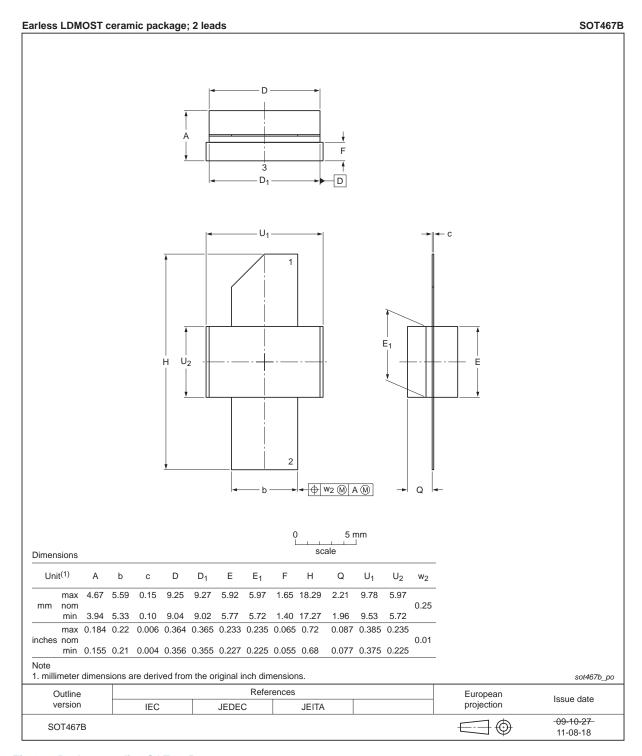


Fig 4. Package outline SOT467B

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9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

10. Abbreviations

Table 9. Abbreviations

Acronym	Description
3GPP	3rd Generation Partnership Project
CDMA	Code Division Multiple Access
CCDF	Complementary Cumulative Distribution Function
DPCH	Dedicated Physical CHannel
EDGE	Enhanced Data rates for GSM Evolution
GSM	Global System for Mobile Communications
HF	High Frequency
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
VSWR	Voltage Standing-Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

11. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF6H10L-160_6H10LS-160 v.1	20120210	Objective data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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BLF6H10L-160; BLF6H10LS-160

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BLF6H10L-160_6H10LS-160

14. Contents

1	Product profile
1.1	General description
1.2	Features and benefits
1.3	Applications
2	Pinning information 2
3	Ordering information
4	Limiting values
5	Thermal characteristics
6	Characteristics 3
7	Application information 4
7.1	Ruggedness in class-AB operation 4
7.2	Impedance information
8	Package outline 5
9	Handling information 7
10	Abbreviations 7
11	Revision history 7
12	Legal information 8
12.1	Data sheet status 8
12.2	Definitions 8
12.3	Disclaimers
12.4	Trademarks 9
13	Contact information 9
14	Contents

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